# **Power MOSFET** 40 V, 123 A, Single N-Channel DPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- MSL 1/260°C
- AEC Q101 Qualified and PPAP Capable
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Motor Drivers
- Pump Drivers for Automotive Braking, Steering and Other High Current Systems

### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	40	V		
Gate-to-Source Voltage	,		V <sub>GS</sub>	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	123	Α
rent (R <sub>θJC</sub> )		T <sub>C</sub> = 85°C		95	
Power Dissipation $(R_{\theta JC})$	Steady	T <sub>C</sub> = 25°C	$P_{D}$	107	W
Continuous Drain Cur-	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	24	Α
rent (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 85°C		18.5	
Power Dissipation $(R_{\theta JA})$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	4.0	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	400	Α
Current Limited by Pack	I <sub>DmaxPkg</sub>	100	Α		
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C		
Source Current (Body Di	I <sub>S</sub>	100	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-S ergy ( $V_{DD}$ = 32 V, $V_{GS}$ = L = 0.3 mH, $I_{L(pk)}$ = 40 A	E <sub>AS</sub>	240	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			$T_L$	260	°C

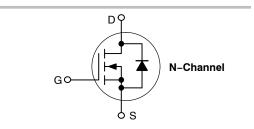
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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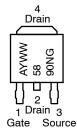
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
40 V	3.7 m $\Omega$ @ 10 V	123 A	





# MARKING DIAGRAMS & PIN ASSIGNMENT

STYLE 2



A = Assembly Location\*

Y = Year

WW = Work Week

5890N = Device Code

G = Pb-Free Package

\* The Assembly Location Code (A) is front side optional. In cases where the Assembly Location is stamped in the package bottom (molding ejecter pin), the front side assembly code may be blank.

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	37	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	76	

Surface-mounted on FR4 board using 650 mm<sup>2</sup> pad size, 2 oz Cu.
 Surface-mounted on FR4 board using 36 mm<sup>2</sup> pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				40		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	$T_{J} = 25^{\circ}C$ $T_{J} = 150^{\circ}C$			1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>				± 100	nA
ON CHARACTERISTICS (Note 3)	<u> </u>		<u>.                                    </u>				1
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.5		3.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A			2.9	3.7	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			16.8		S
CHARGES AND CAPACITANCES	•						
Input Capacitance	C <sub>iss</sub>				4975		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V, f} = 1$ $V_{DS} = 12$			785		
Reverse Transfer Capacitance	C <sub>rss</sub>	108 12 1			490		
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			4760		pF
Output Capacitance	C <sub>oss</sub>				580		
Reverse Transfer Capacitance	C <sub>rss</sub>				385		
Total Gate Charge	Q <sub>G(TOT)</sub>				74	100	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 10 V, $V_{D}$	s = 15 V,		5.0		1
Gate-to-Source Charge	$Q_{GS}$	$I_{D} = 50 \text{ A}$			17		1
Gate-to-Drain Charge	$Q_{GD}$				16		1
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, $I_{D}$ = 50 A, $R_{G}$ = 2.0 $\Omega$			14		ns
Rise Time	t <sub>r</sub>				55		1
Turn-Off Delay Time	t <sub>d(off)</sub>				35		1
Fall Time	t <sub>f</sub>				7.0		

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	T <sub>J</sub> = 25°C		0.9	1.2	V	
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A	T <sub>J</sub> = 25°C		0.8	1.0		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dIs/dt = 100 A/ $\mu$ s, I <sub>S</sub> = 50 A			35		ns	
Charge Time	ta				20		1	
Discharge Time	tb				15			
Reverse Recovery Charge	$Q_{RR}$				40		nC	

#### **TYPICAL PERFORMANCE CURVES**

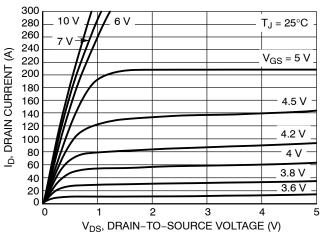


Figure 1. On-Region Characteristics

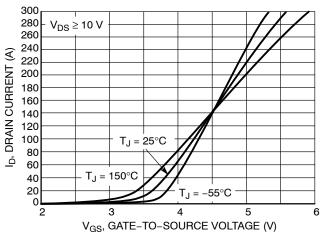


Figure 2. Transfer Characteristics

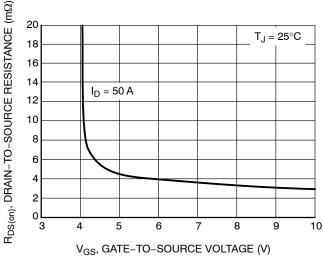


Figure 3. On-Resistance vs. Drain Current

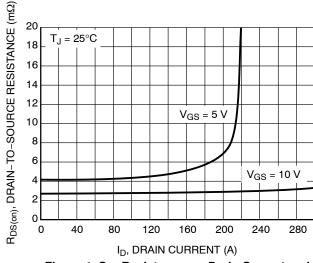


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

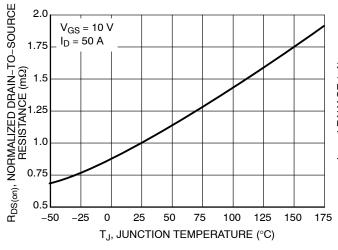


Figure 5. On–Resistance Variation with Temperature

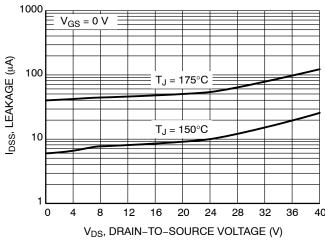


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**

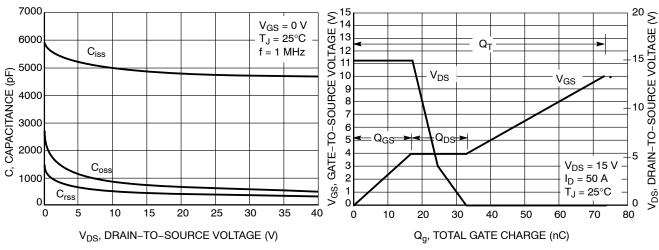


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

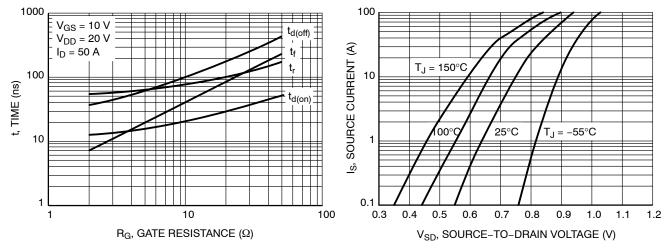


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

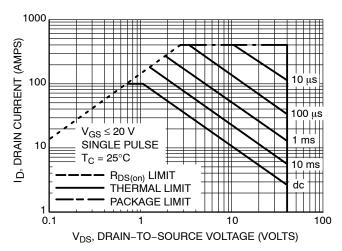


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### **TYPICAL PERFORMANCE CURVES**

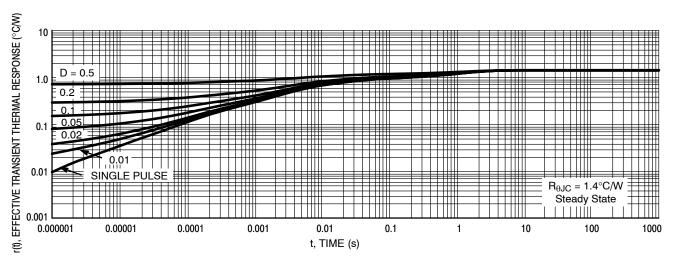


Figure 12. Thermal Response

#### **ORDERING INFORMATION**

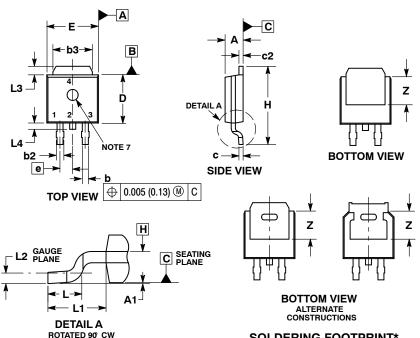
Order Number	Package	Shipping <sup>†</sup>
NVD5890NT4G	DPAK (Pb-Free)	2500/Tape & Reel
NVD5890NT4G-VF01	DPAK (Pb-Free)	2500/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### **DPAK (SINGLE GAUGE)**

CASE 369C **ISSUE F** 



- OTLS.

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

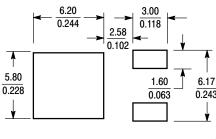
  2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

  6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114	REF	2.90 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE 2. DRAIN
  - 3 SOURCE
  - 4. DRAIN

# **SOLDERING FOOTPRINT\***



(mm inches SCALE 3:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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